PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Robert E. Higashi et al.

Examiner: unknown

Serial No.

10/750,580

Group Art Unit: unknown

Filed:

December 29, 2003

Confirmation No.: unknown

For:

AN INTEGRAL TOPSIDE VACUUM PACKAGE

Docket No.:

H0004490 (1100.1226101)

TRANSMITTAL SHEET

Assistant Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

CERTIFICATE UNDER 37 C.F.R. 1.8: I hereby certify that this correspondence is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the:

Commissioner for Patents, PO Box 1450, Alexandria, VA 22313-1450, on this 29th __day of _April__, 2004.

By: John G. Shudy, Jr.

We are transmitting herewith the attached:

[X]

Information Disclosure Statement, Form PTO-1449 listing 5 references with 1

non-US patent reference attached.

[X]

Please charge any deficiencies or credit any overpayment in the enclosed fees to

Deposit Account No. 50-0413.

John G. Shudy, Jr., Reg. No. 31,214

CROMPTON, SEAGER & TUFTE, LLC

1221 Nicollet Avenue, Suite 800 Minneapolis, Minnesota 55403-2420

Telephone: (612) 677-9050 Facsimile: (612) 359-9349

PATENT

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INFORMATION DISCLOSURE STATEMENT (37 C.F.R. §1.97(b))

Assistant Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

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Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the:

Commissioner for Patents, PO Box 1450, Alexandria, VA 22313-1450, on this _29th__ day of _April__, 2004.

By: John G. Shudy, Jr.

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner.

This statement should be considered because it is submitted before the mailing date of a first Office Action on-the-merits. Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

In accordance with 37 C.F. R. §1.98(a)(2), a copy of each non-US patent document or other information listed on the enclosed Form 1449 is provided.

No representation is intended to be made hereby that any of the cited references establishes, by itself or in combination with other information, a prima facie case of unpatentability of any claim of the present case.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Respectfully submitted, Robert E. Higashi et al. By their attorney,

Dated: 04-29-04

John G. Shudy, Jr., Reg. No. 31,214

CROMPTON, SEAGER & TUFTE, LLC

1221 Nicollet Avenue, Suite 800

Minneapolis, MN 55403-2402

Telephone: (612) 677-9050

Facsimile: (612) 359-9349

Page 1 of 1 Atty. Docket No.: H0004490(1100.1226101) Applicant: Robert E. Higashi et al. Applicant: Serial No.: 10/750,580 Applicant: Robert E. Higashi et al. Filing Date: December 29, 2003 unknown

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	
	5,895,233	04/1999	Higashi et al.	
	6,036,872	03/2000	Wood et al.	
	6,359,333	03/2002	Wood et al.	
	6,627,892	09/2003	Cole	

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Country	Translation Yes No
				105 140

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

	Motamedi et al., "Antireflection Surfaces in Silicon Using Binary Optics Technology," Applied Optics, Vol. 31, No. 2, pp. 4371-4376, August 1, 1002.		
EXAMINER:	DATE CONSIDERED:		

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.